

Search Notes

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Examiner

Jason M. Han

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	260	6/20/2005	JMH
362	646	6/20/2005	JMH
362	217-225	6/20/2005	JMH
439	56	6/20/2005	JMH
439	235	6/20/2005	JMH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update	6/20/2005	JMH
P.E. Stephen Husar	6/20/2005	JMH